

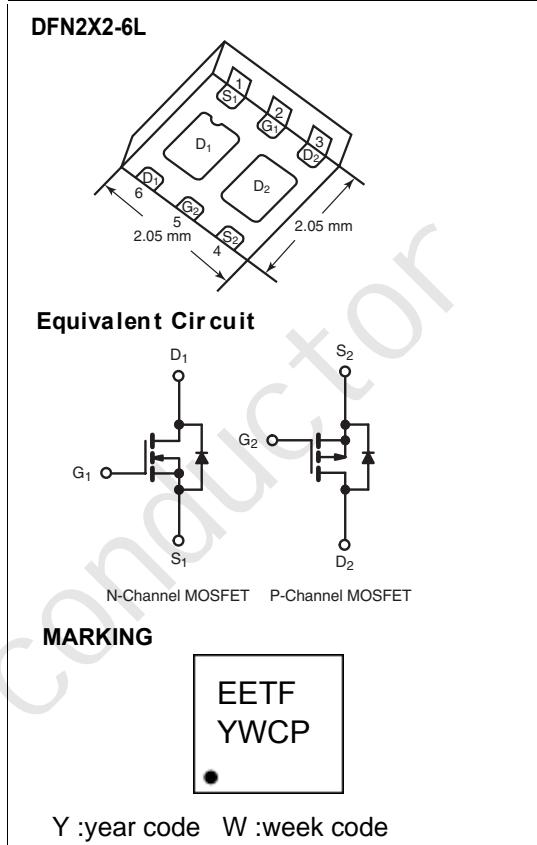
PRODUCT SUMMARY				
	V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A)	Q_g (Typ.)
N-Channel	12	0.029 at $V_{GS} = 4.5$ V	4.5 ^a	5.6 nC
		0.034 at $V_{GS} = 2.5$ V	4.5 ^a	
		0.044 at $V_{GS} = 1.8$ V	4.5 ^a	
		0.065 at $V_{GS} = 1.5$ V	4.5 ^a	
P-Channel	- 12	0.061 at $V_{GS} = - 4.5$ V	- 4.5 ^a	8.2 nC
		0.081 at $V_{GS} = - 2.5$ V	- 4.5 ^a	
		0.115 at $V_{GS} = - 1.8$ V	- 4.5 ^a	
		0.170 at $V_{GS} = - 1.5$ V	- 4.5 ^a	

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Power MOSFETs
- New Thermally Enhanced PowerPAK® SC-70 Package
 - Small Footprint Area
 - Low On-Resistance
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Load Switch for Portable Devices



ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted				
Parameter	Symbol	N-Channel	P-Channel	Unit
Drain-Source Voltage	V_{DS}	12	- 12	V
Gate-Source Voltage	V_{GS}	± 8		
Continuous Drain Current ($T_J = 150$ °C)	I_C = 25 °C	I_D	4.5 ^a	A
	$T_A = 25$ °C		4.5 ^{a, b, c}	
Pulsed Drain Current	I_{DM}	20	- 15	
Source Drain Current Diode Current	$T_C = 25$ °C	I_S	4.5 ^a	
	$T_A = 25$ °C		1.6 ^{b, c}	
Maximum Power Dissipation	$T_C = 25$ °C	P_D	6.5	W
	$T_A = 25$ °C		1.9 ^{b, c}	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to 150		°C
Soldering Recommendations (Peak Temperature) ^{d, e}		260		

THERMAL RESISTANCE RATINGS					
Parameter	Symbol	N-Channel		P-Channel	Unit
		Typ.	Max.		
Maximum Junction-to-Ambient ^{b, f}	R_{thJA}	t ≤ 5 s	52	65	52
Maximum Junction-to-Case (Drain)	R_{thJC}	Steady State	12.5	16	16

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.

N- and P-Channel 12-V (D-S) MOSFET

 Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted								
Parameter	Symbol	Test Conditions			Min.	Typ.	Max.	Unit
Static								
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	N-Ch P-Ch	12				V
		$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		- 12				
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250 \mu\text{A}$	N-Ch P-Ch		12			$\text{mV}/^\circ\text{C}$
		$I_D = -250 \mu\text{A}$				- 3.1		
$V_{GS(\text{th})}$ Temperature Coefficient	$\Delta V_{GS(\text{th})}/T_J$	$I_D = 250 \mu\text{A}$	N-Ch P-Ch		- 2.5			
		$I_D = -250 \mu\text{A}$				2.4		
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	N-Ch P-Ch	0.4		1		V
		$V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$		- 0.4		- 1		
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	N-Ch P-Ch			± 100		nA
						± 100		
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 12 \text{ V}, V_{GS} = 0 \text{ V}$	N-Ch P-Ch			1		μA
		$V_{DS} = -12 \text{ V}, V_{GS} = 0 \text{ V}$				- 1		
On-State Drain Current ^b	$I_{D(\text{on})}$	$V_{DS} \geq 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	N-Ch P-Ch	15				A
		$V_{DS} \leq -5 \text{ V}, V_{GS} = -4.5 \text{ V}$		- 10				
Drain-Source On-State Resistance ^b	$R_{DS(\text{on})}$	$V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	N-Ch P-Ch		0.024	0.029		Ω
		$V_{GS} = -4.5 \text{ V}, I_D = -3.6 \text{ A}$			0.050	0.061		
		$V_{GS} = 2.5 \text{ V}, I_D = 4.6 \text{ A}$	N-Ch P-Ch		0.028	0.034		
		$V_{GS} = -2.5 \text{ V}, I_D = -3.2 \text{ A}$			0.066	0.081		
		$V_{GS} = 1.8 \text{ V}, I_D = 4.1 \text{ A}$	N-Ch P-Ch		0.032	0.044		
		$V_{GS} = -1.8 \text{ V}, I_D = -1 \text{ A}$			0.093	0.115		
Forward Transconductance ^b	g_{fs}	$V_{DS} = 10 \text{ V}, I_D = 5 \text{ A}$	N-Ch P-Ch		21			S
		$V_{DS} = -10 \text{ V}, I_D = -3.6 \text{ A}$				11		
Dynamic^a								
Input Capacitance	C_{iss}	<p style="text-align: center;">N-Channel $V_{DS} = 6 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$</p> <p style="text-align: center;">P-Channel $V_{DS} = -6 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$</p>	N-Ch P-Ch		500			pF
Output Capacitance	C_{oss}				590			
Reverse Transfer Capacitance	C_{rss}		N-Ch P-Ch		160			
Total Gate Charge	Q_g				280			
Gate-Source Charge	Q_{gs}		N-Ch P-Ch		100			
Gate-Drain Charge	Q_{gd}				250			
Gate Resistance	R_g	$f = 1 \text{ MHz}$	N-Ch P-Ch		9.7	15		nC
					13.1	20		
		<p style="text-align: center;">N-Channel $V_{DS} = 6 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 6.5 \text{ A}$</p> <p style="text-align: center;">P-Channel $V_{DS} = -6 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -4.3 \text{ A}$</p>	N-Ch P-Ch		5.6	8.5		nC
					8.2	12.5		
			N-Ch P-Ch		0.72			
					1.2			
			N-Ch P-Ch		0.74			
					2.8			
			N-Ch P-Ch	0.7	3.5	7		Ω
				2	10	20		

Notes:

a. Guaranteed by design, not subject to production testing.

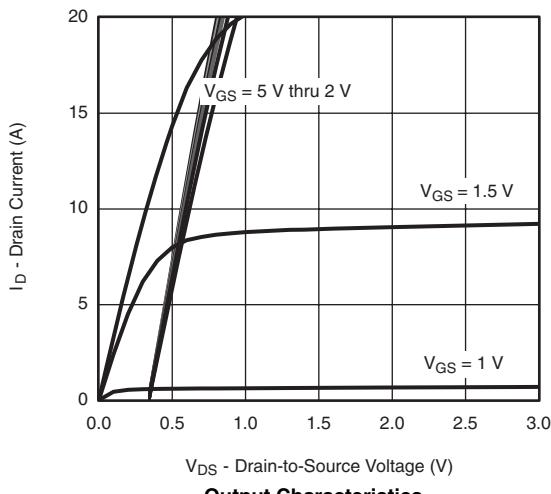
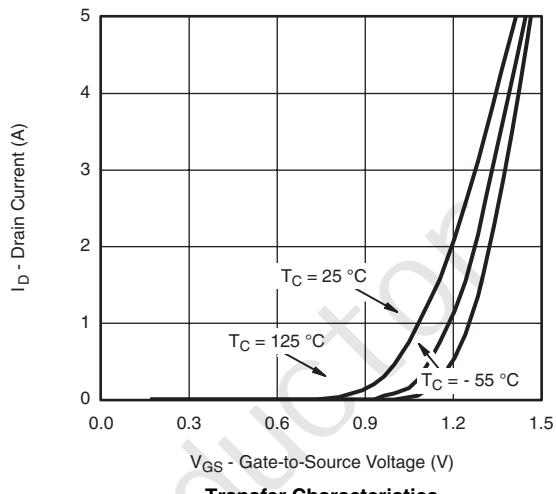
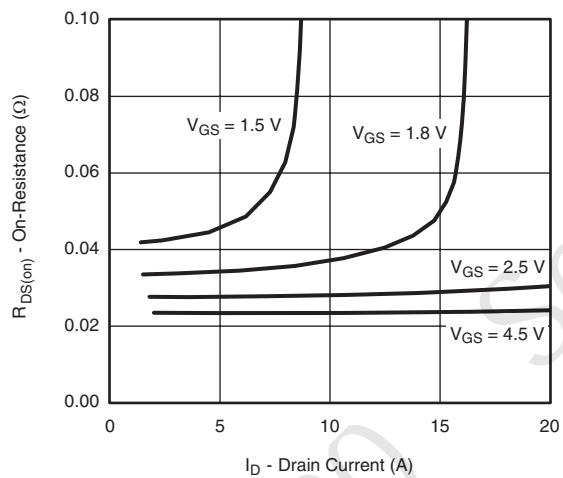
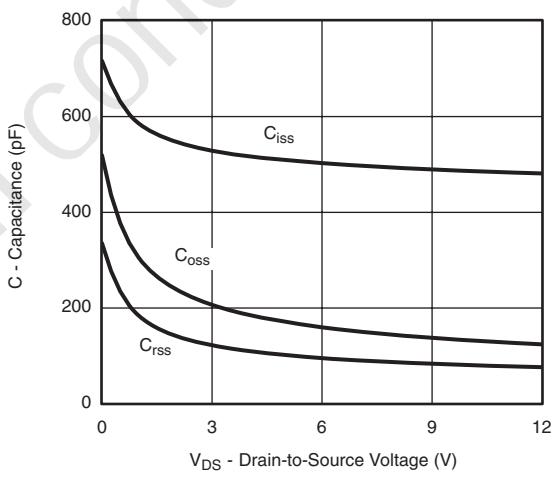
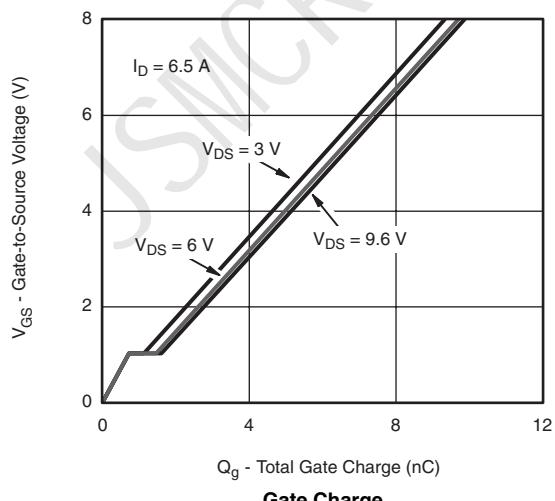
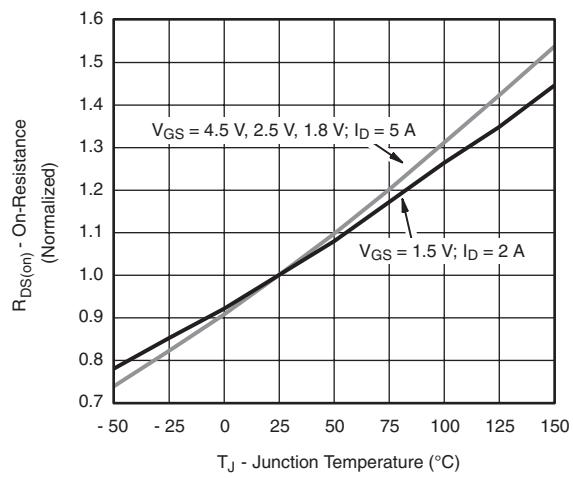
 b. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.

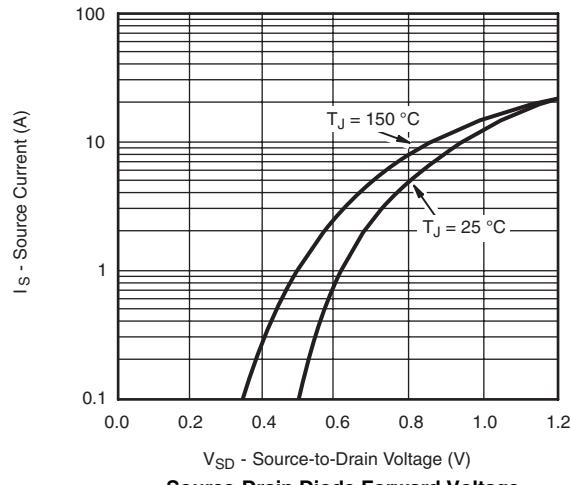
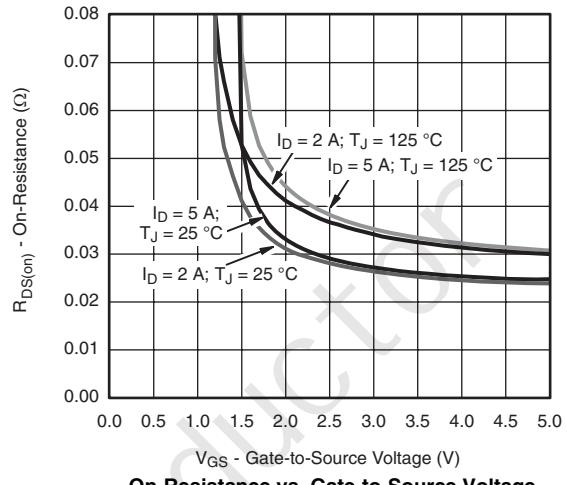
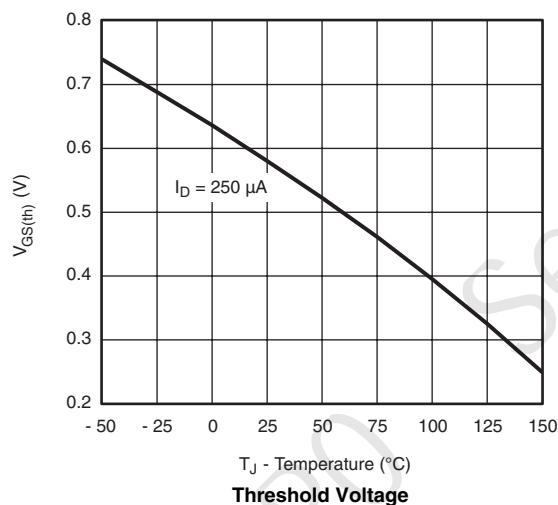
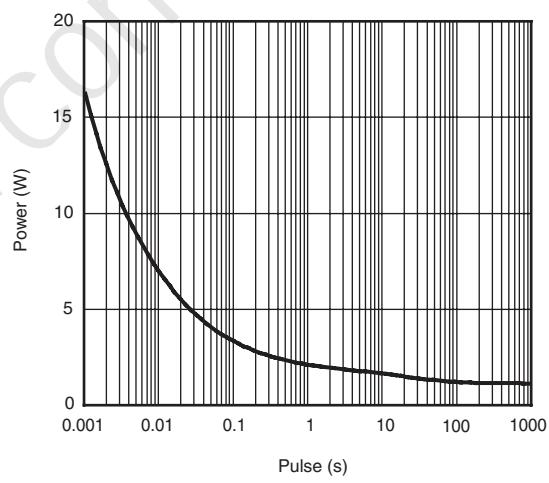
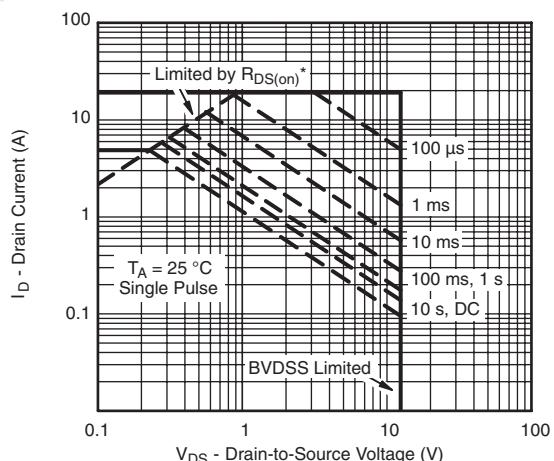
Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

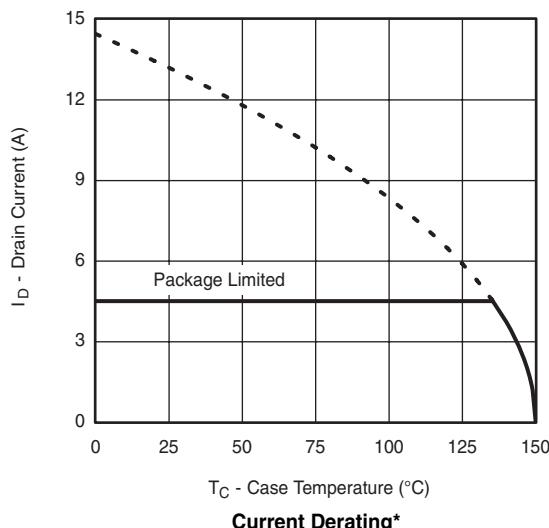
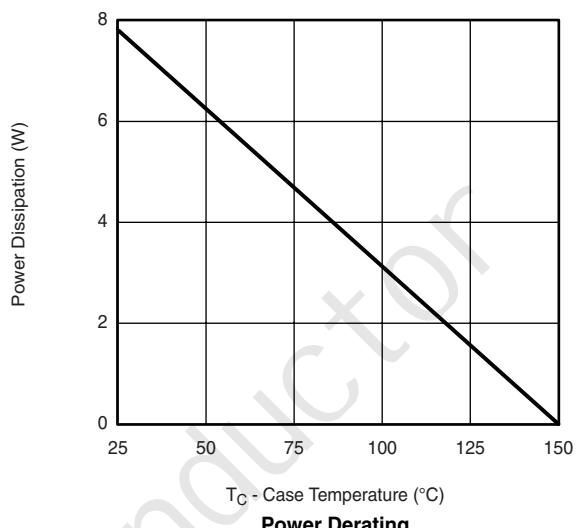
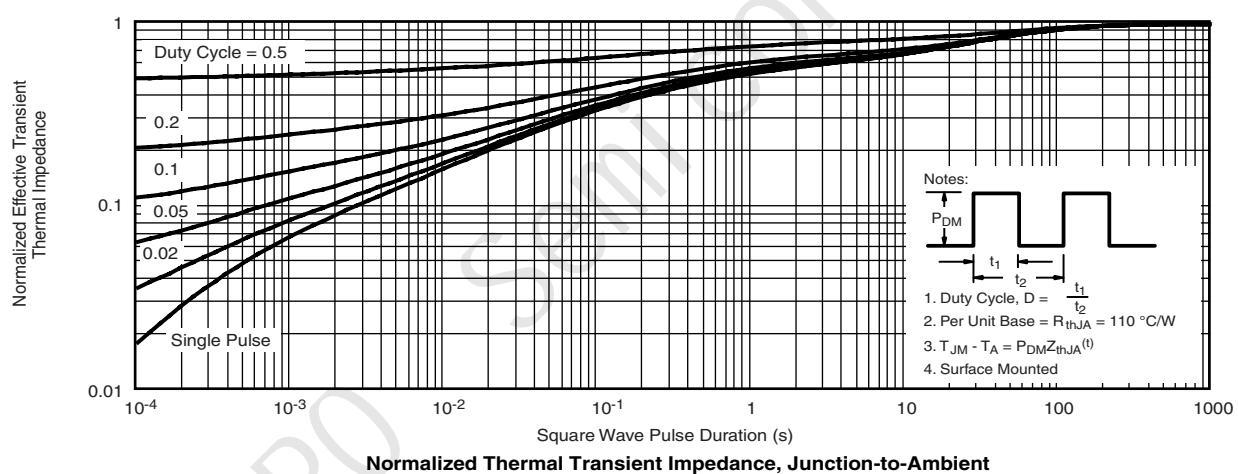
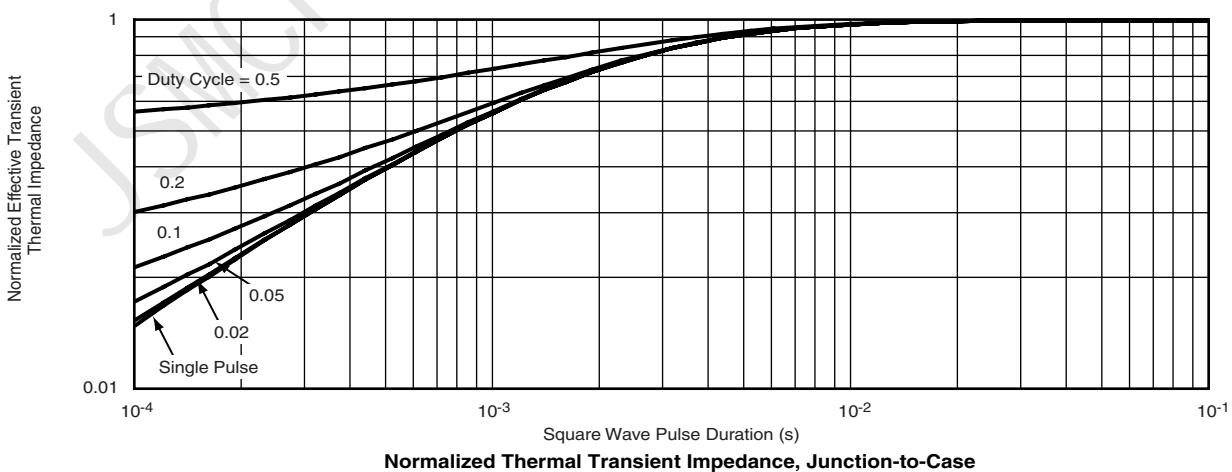
SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted								
Parameter	Symbol	Test Conditions			Min.	Typ.	Max.	Unit
Dynamic^a								
Turn-On Delay Time	$t_{d(on)}$	N-Channel $V_{DD} = 6 \text{ V}, R_L = 1.2 \Omega$ $I_D \approx 5.2 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	N-Ch		10	15		ns
Rise Time	t_r		P-Ch		30	40		
Turn-Off Delay Time	$t_{d(off)}$		N-Ch		10	15		
Fall Time	t_f		P-Ch		25	40		
Turn-On Delay Time	$t_{d(on)}$		N-Ch		22	30		
Rise Time	t_r		P-Ch		30	45		
Turn-Off Delay Time	$t_{d(off)}$		N-Ch		10	15		
Fall Time	t_f		P-Ch		20	30		
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	I_S	$T_C = 25^\circ\text{C}$	N-Ch			4.5		A
Pulse Diode Forward Current ^a	I_{SM}		P-Ch			- 4.5		
Body Diode Voltage	V_{SD}	$I_S = 5.2 \text{ A}, V_{GS} = 0 \text{ V}$ $I_S = - 3.4 \text{ A}, V_{GS} = 0 \text{ V}$	N-Ch		0.85	1.2		V
Body Diode Reverse Recovery Time	t_{rr}		P-Ch		- 0.8	- 1.2		
Body Diode Reverse Recovery Charge	Q_{rr}	N-Channel $I_F = 5.2 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, T_J = 25^\circ\text{C}$ P-Channel $I_F = - 3.8 \text{ A}, dI/dt = - 100 \text{ A}/\mu\text{s}, T_J = 25^\circ\text{C}$	N-Ch		20	40		ns
Reverse Recovery Fall Time	t_a		P-Ch		30	60		
Reverse Recovery Rise Time	t_b		N-Ch		5	10		nC
			P-Ch		12	24		
			N-Ch		8			ns
			P-Ch		16			
			N-Ch		12			ns
			P-Ch		14			

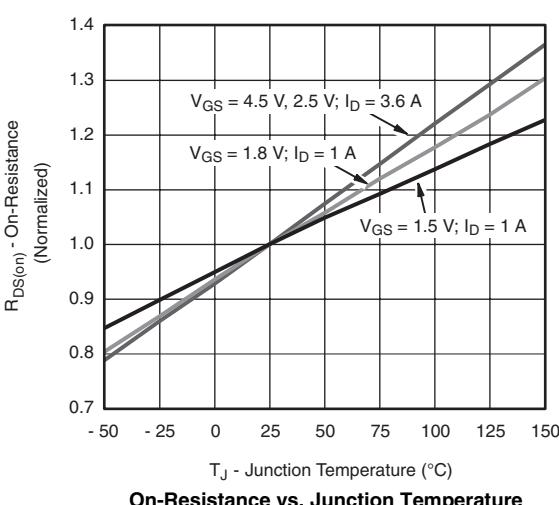
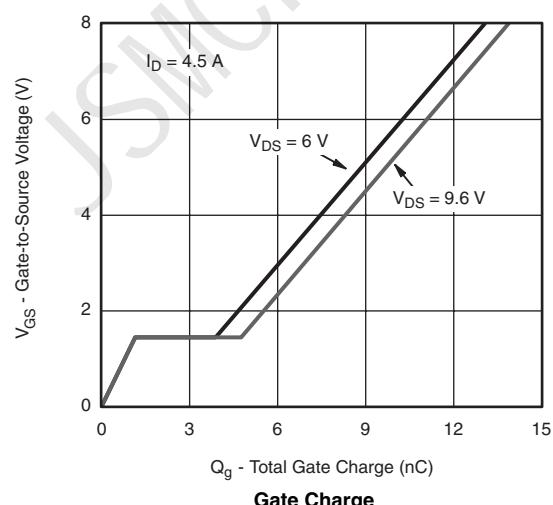
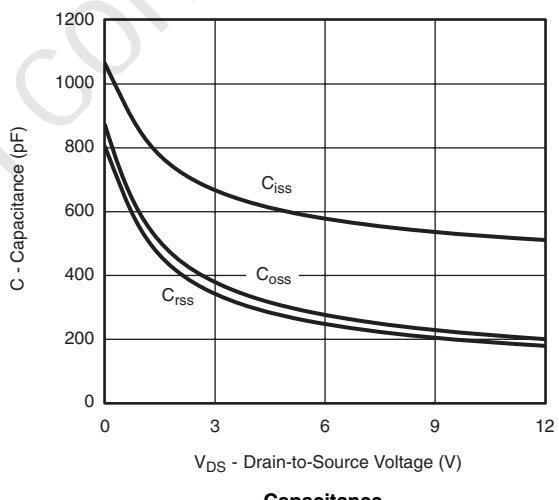
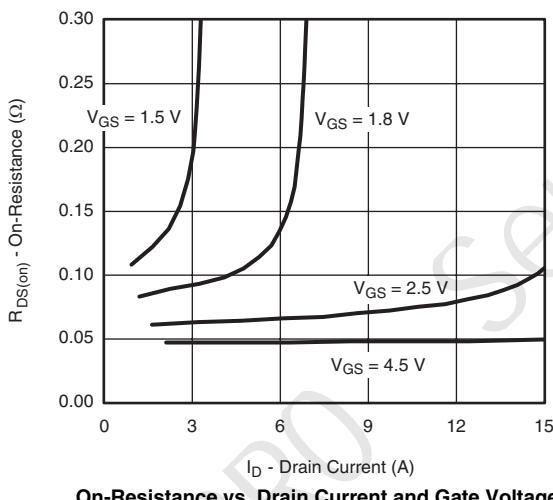
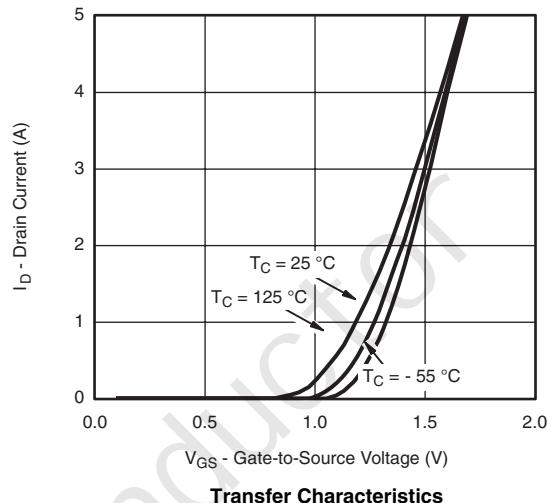
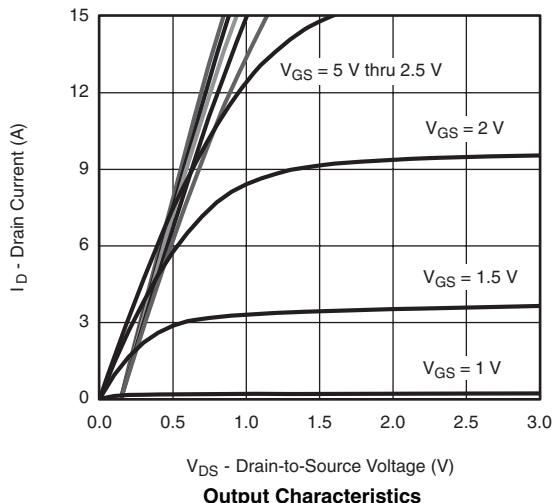
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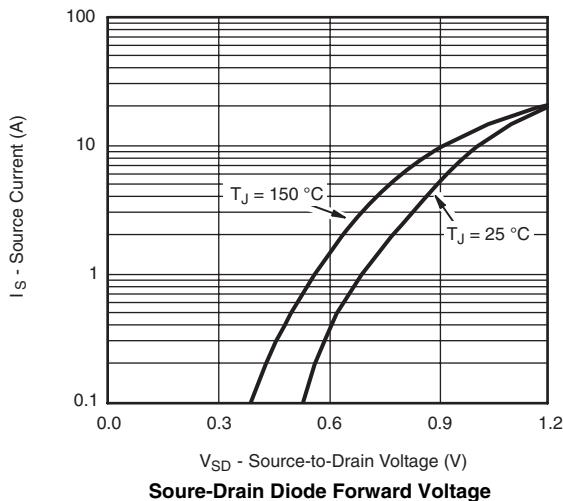
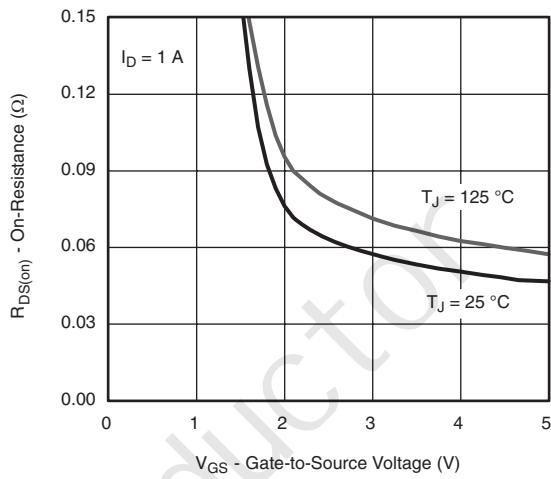
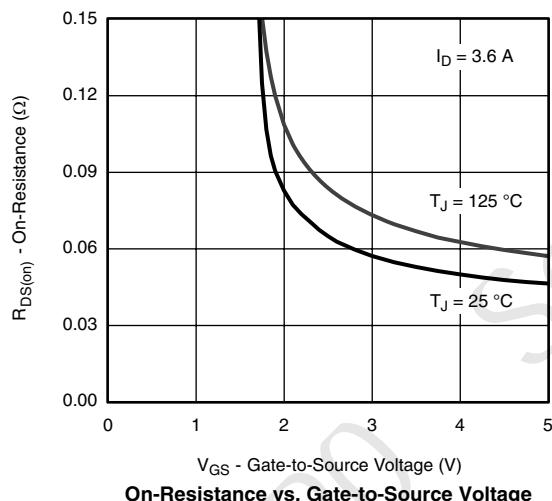
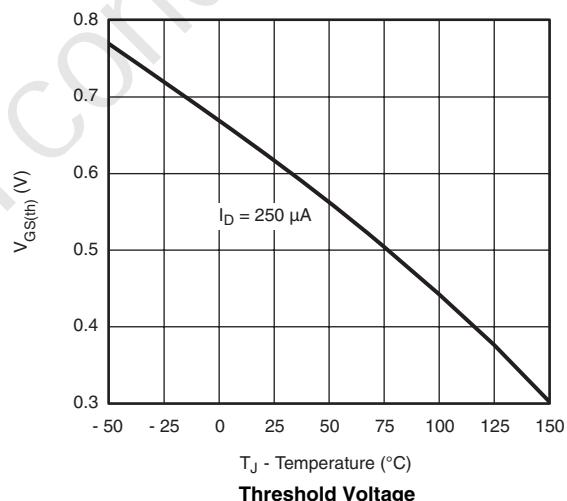
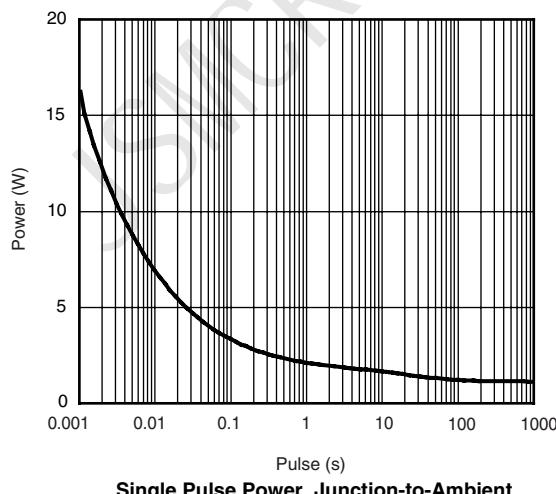
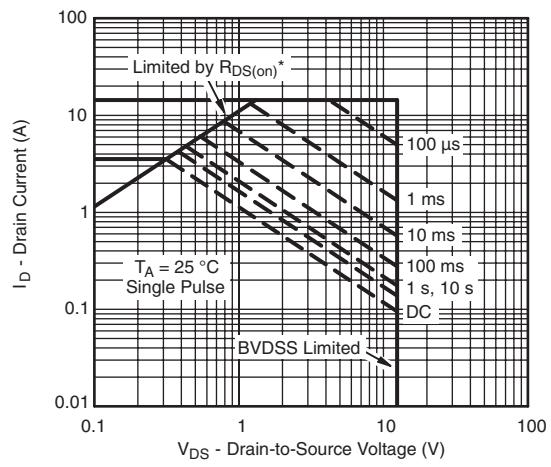
- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.

N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Output Characteristics

Transfer Characteristics

On-Resistance vs. Drain Current and Gate Voltage

Capacitance

Gate Charge

On-Resistance vs. Junction Temperature

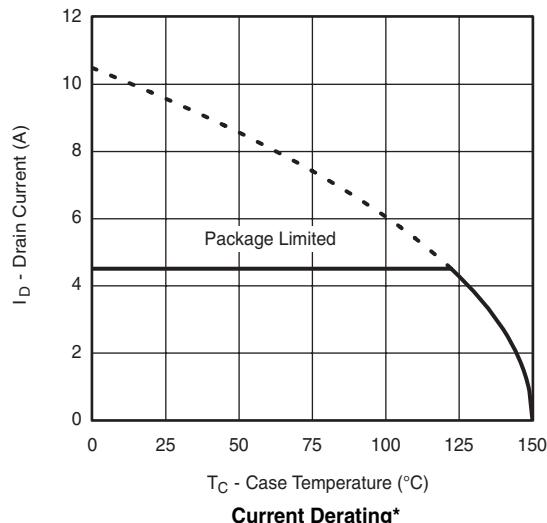
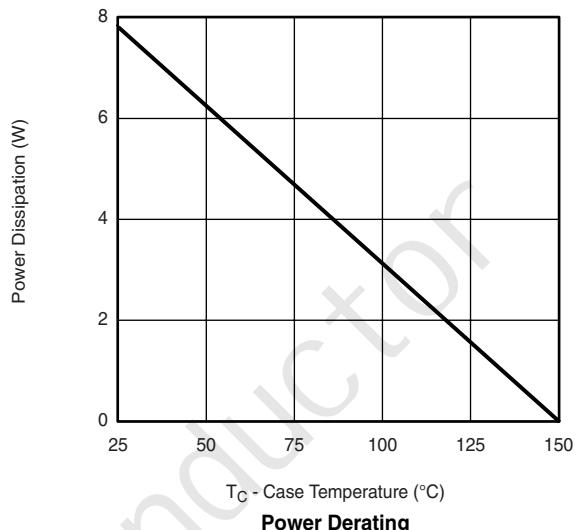
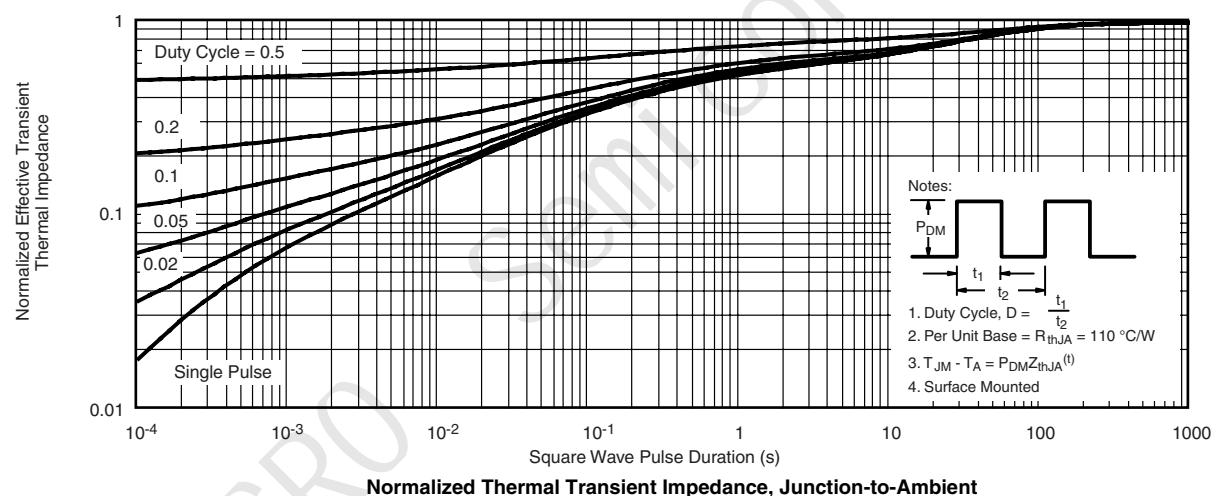
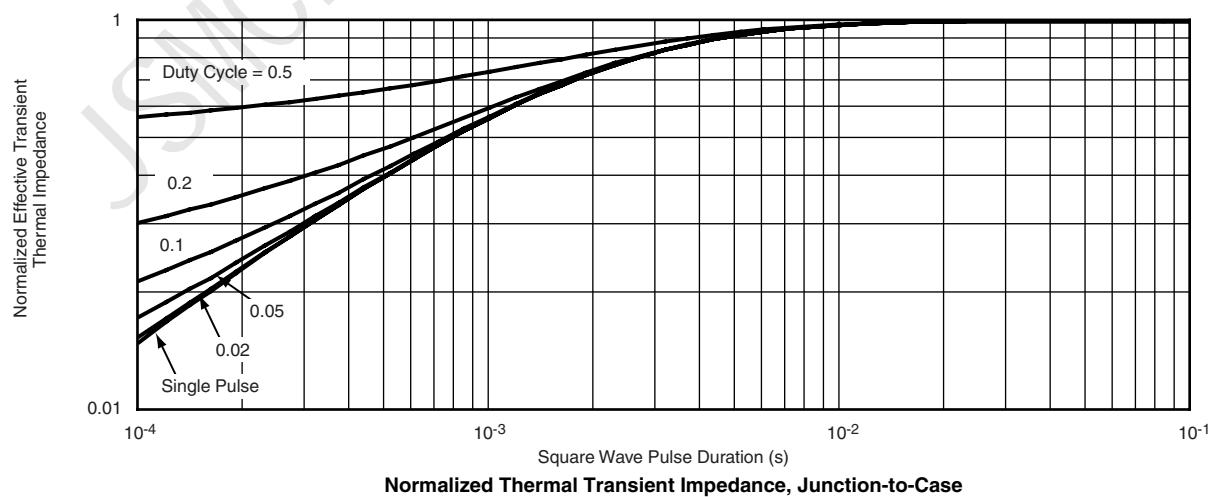
N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Source-Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage

Threshold Voltage

Single Pulse Power (Junction-to-Ambient)

 $* V_{GS} > \text{minimum } V_{GS} \text{ at which } R_{DS(on)} \text{ is specified}$
Safe Operating Area, Junction-to-Ambient

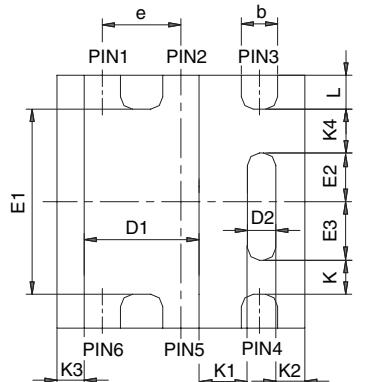
N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Current Derating*

Power Derating

Normalized Thermal Transient Impedance, Junction-to-Ambient

Normalized Thermal Transient Impedance, Junction-to-Case

P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted


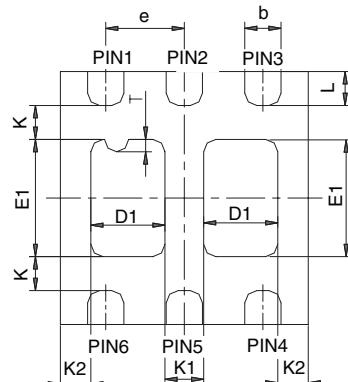
P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Source-Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage

On-Resistance vs. Gate-to-Source Voltage

Threshold Voltage

Single Pulse Power, Junction-to-Ambient


* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified
Safe Operating Area, Junction-to-Ambient

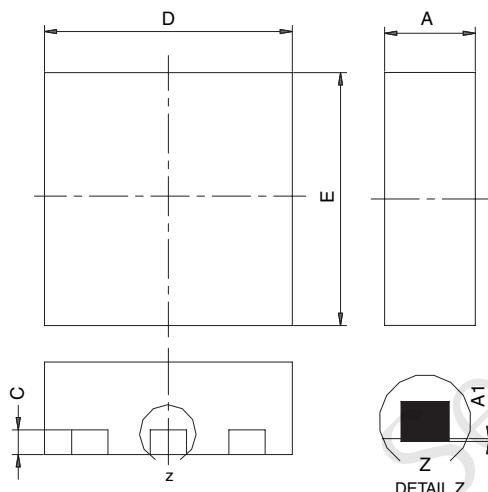
P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Current Derating*

Power Derating

Normalized Thermal Transient Impedance, Junction-to-Ambient

Normalized Thermal Transient Impedance, Junction-to-Case



BACKSIDE VIEW OF SINGLE



BACKSIDE VIEW OF DUAL



Notes:
 1. All dimensions are in millimeters
 2. Package outline exclusive of mold flash and metal burr
 3. Package outline inclusive of plating

DIM	SINGLE PAD						DUAL PAD					
	MILLIMETERS			INCHES			MILLIMETERS			INCHES		
	Min	Nom	Max	Min	Nom	Max	Min	Nom	Max	Min	Nom	Max
A	0.675	0.75	0.80	0.027	0.030	0.032	0.675	0.75	0.80	0.027	0.030	0.032
A1	0	-	0.05	0	-	0.002	0	-	0.05	0	-	0.002
b	0.23	0.30	0.38	0.009	0.012	0.015	0.23	0.30	0.38	0.009	0.012	0.015
C	0.15	0.20	0.25	0.006	0.008	0.010	0.15	0.20	0.25	0.006	0.008	0.010
D	1.98	2.05	2.15	0.078	0.081	0.085	1.98	2.05	2.15	0.078	0.081	0.085
D1	0.85	0.95	1.05	0.033	0.037	0.041	0.513	0.613	0.713	0.020	0.024	0.028
D2	0.135	0.235	0.335	0.005	0.009	0.013						
E	1.98	2.05	2.15	0.078	0.081	0.085	1.98	2.05	2.15	0.078	0.081	0.085
E1	1.40	1.50	1.60	0.055	0.059	0.063	0.85	0.95	1.05	0.033	0.037	0.041
E2	0.345	0.395	0.445	0.014	0.016	0.018						
E3	0.425	0.475	0.525	0.017	0.019	0.021						
e	0.65 BSC			0.026 BSC			0.65 BSC			0.026 BSC		
K	0.275 TYP			0.011 TYP			0.275 TYP			0.011 TYP		
K1	0.400 TYP			0.016 TYP			0.320 TYP			0.013 TYP		
K2	0.240 TYP			0.009 TYP			0.252 TYP			0.010 TYP		
K3	0.225 TYP			0.009 TYP								
K4	0.355 TYP			0.014 TYP								
L	0.175	0.275	0.375	0.007	0.011	0.015	0.175	0.275	0.375	0.007	0.011	0.015
T							0.05	0.10	0.15	0.002	0.004	0.006

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 DWG: 5934